

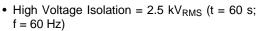
SSU65R2K3S-VB Datasheet

N-Channel 650V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	650			
R _{DS(on)} (Ω)	V _{GS} = 10 V	2.3		
Q _g (Max.) (nC)	31			
Q _{gs} (nC)	4.6			
Q _{gd} (nC)	17			
Configuration	Single			

FEATURES



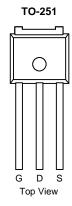


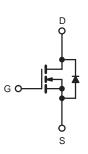


- Dynamic dV/dt Rating
- · Low Thermal Resistance
- · Lead (Pb)-free Available









N-Channel MOSFET

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	650	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V _{GS} at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	1	2.0	А	
		T _C = 100 °C	I _D	1.6		
Pulsed Drain Current ^a			I _{DM}	10		
Linear Derating Factor				0.28	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	250	mJ	
Repetitive Avalanche Current ^a			I _{AR}	1.5	А	
Repetitive Avalanche Energy ^a			E _{AR}	3.5	mJ	
Maximum Power Dissipation	num Power Dissipation $T_C = 25 ^{\circ}C$		P_{D}	35	W	
Peak Diode Recovery dV/dt ^c			dV/dt	3.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for	10 s	,	300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. V_{DD} = 50 V, starting T_J = 25 °C, L = 73 mH, R_G = 25 Ω , I_{AS} = 1.5 A (see fig. 12).
- c. $I_{SD} \le 1.6$ A, $dI/dt \le 60$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C. d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.6	C/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							•
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		650	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.62	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V	-	-	± 100	nA
Zara Cata Valtaga Drain Current		V _{DS} = 650 V, V _{GS} = 0 V		-	-	100	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 480 \	/, V _{GS} = 0 V, T _J = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 1.5 A ^b	-	2.3	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D = 1.5 A ^b	2.2	-	-	S
Dynamic							•
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	660	-	
Output Capacitance	C _{oss}		$V_{DS} = 25 \text{ V},$	-	86	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	19	-	
Drain to Sink Capacitance	С		f = 1.0 MHz	-	12	-	
Total Gate Charge	Qg			-	-	31	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 1.6 \text{ A}, V_{DS} = 360 \text{ V},$ see fig. 6 and 13 ^b	_	-	4.6	nC
Gate-Drain Charge	Q _{gd}		See fig. 6 and 15	-	-	17	
Turn-On Delay Time	t _{d(on)}			-	11	-	
Rise Time	t _r	$V_{DD} = 300 \text{ V, } I_D = 1.6 \text{ A,}$ $R_G = 12 \Omega, R_D = 82 \Omega,$ see fig. 10^b		-	13	-	- ns
Turn-Off Delay Time	t _{d(off)}			-	35	-	
Fall Time	t _f			-	14	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	-11
Internal Source Inductance	L _S			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s					<u>'</u>	,
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.0	Α
Pulsed Diode Forward Current ^a	I _{SM}			i	-	10	^
Body Diode Voltage	V_{SD}	T _J = 25 °C	$I_{S} = 1.5 \text{ A}, V_{GS} = 0 \text{ V}^{b}$	-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	T. = 25 °C 1	- 1 6 A dl/dt - 100 A/ush	-	400	810	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 \text{ °C}, I_F = 1.6 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s}^b$		-	2.1	4.2	μC
Forward Turn-On Time	t _{on}	Intrinsic to	ırn-on time is negligible (turn	on is don	ninated by	_y L _S and I	_D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

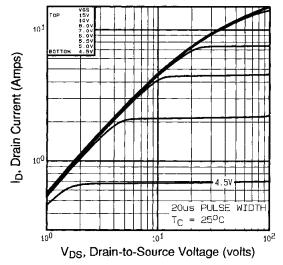


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

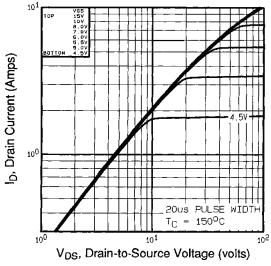


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

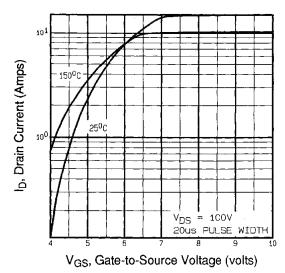


Fig. 3 - Typical Transfer Characteristics

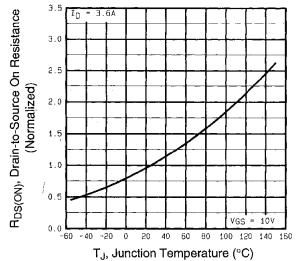


Fig. 4 - Normalized On-Resistance vs. Temperature



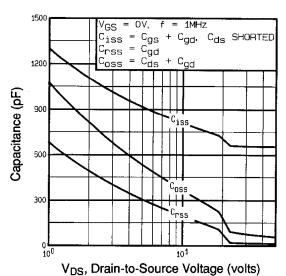


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

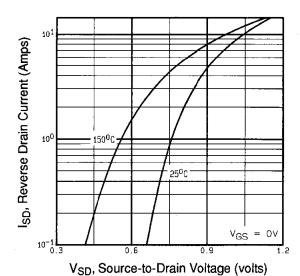


Fig. 7 - Typical Source-Drain Diode Forward Voltage

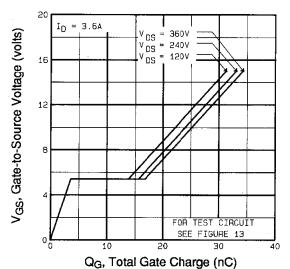


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

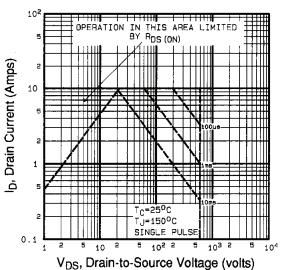


Fig. 8 - Maximum Safe Operating Area



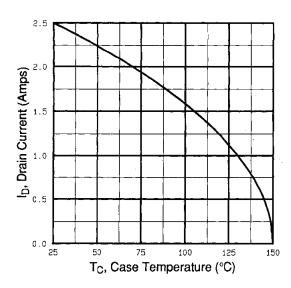


Fig. 9 - Maximum Drain Current vs. Case Temperature

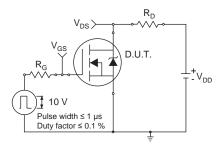


Fig. 10a - Switching Time Test Circuit

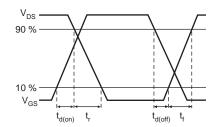


Fig. 10b - Switching Time Waveforms

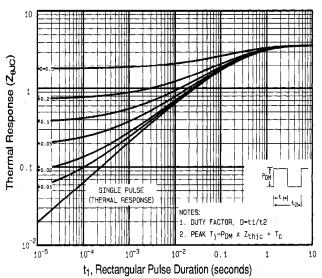


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

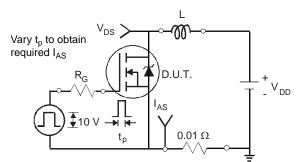


Fig. 12a - Unclamped Inductive Test Circuit

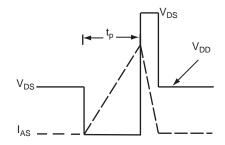


Fig. 12b - Unclamped Inductive Waveforms



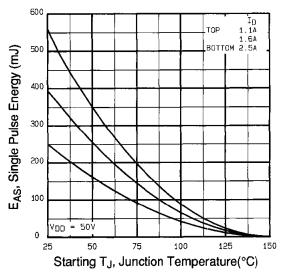


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

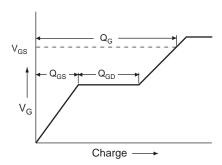


Fig. 13a - Basic Gate Charge Waveform

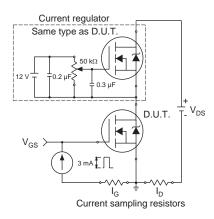
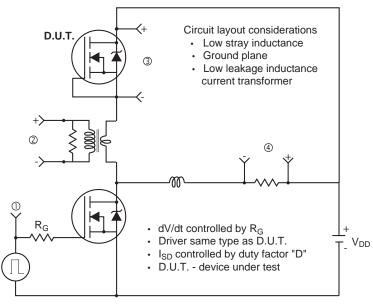


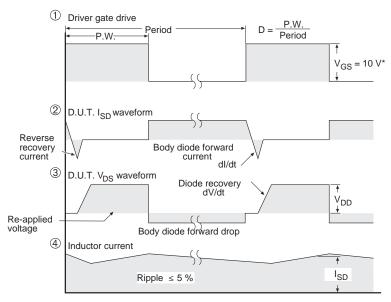
Fig. 13b - Gate Charge Test Circuit



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Peak Diode Recovery dV/dt Test Circuit



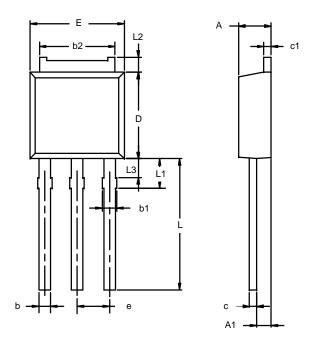


* V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel



TO-251AA (DPAK)



Note: Dimension L3 is for reference only.

	MILLIM	IETERS	INCHES		
Dim	Min	Max	Min	Max	
Α	2.21	2.38	0.087	0.094	
A1	0.89	1.14	0.035	0.045	
b	0.71	0.89	0.028	0.035	
b1	0.76	1.14	0.030	0.045	
b2	5.23	5.43	0.206	0.214	
С	0.46	0.58	0.018	0.023	
с1	0.46	0.58	0.018	0.023	
D	5.97	6.22	0.235	0.245	
Е	6.48	6.73	0.255	0.265	
е	2.28 BSC		0.090 BSC		
L	8.89	9.53	0.350	0.375	
L1	1.91	2.28	0.075	0.090	
L2	0.89	1.27	0.035	0.050	
L3	1.15	1.52	0.045	0.060	



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